

TEST REPORT

Report No. A-0	047-13-V					Date of Is	sue: 3 M	arch 2014
	Departmen	t of Defense Inte	erface Standard	Military Sta	ndard 461	□E ⊠I	310	
The results of	t is to certify the	nat the device would not be constant wal by the document	as tested accordingly	ding to the recompliance of	quirements of devices of	of the ab ther than	ove.	ole tested.
1. Applicant								
Company N	Vame	: IT Product	s Business Div	ision, AVC n	etworks co	mpany, P	anasonic	Corporation
Mailing Ad	ldress		ngumo-higashi-			HE 37.		es Tablida
2. Identification	on of Tested I	Device						
Device Nar Model Num Serial Num Trade Nam Type of Tes Test Plan N	me nber ber e st	: Personal C : FZ-M1 : 3KTSA000 : Panasonic : □ Product : KEC-G111		Date:2014-2-	3			'pose
						in in its		
CE102, Co CS101, Co CS106, Co CS114, Co CS115, Co CS116, Co RE101, Ra RE102, Ra RS101, Ra RS103, Ra Refer the (*1) DU	onducted Emissionducted Suscionducted Suscionducted Suscionducted Suscionducted Suscionducted Suscionducted Emissionducted Emissiondiated Emissiondiated Susceptional Susception of Specification of Tables and Tables and Susception of Specification of Tables and Susception	sions, Power Lesions, Power Lesions, Power Leeptibility, Power eptibility, Transieptibility, Bulk (eptibility, Bulk (eptibility, Damper Leads ons, Magnetic Fons, Electric Fietibility, Magnetitibility, Electric s) with respect t	ads Leads Leads Leads Leats, Power Le Cable Injection Cable Injection ed Sinusoidal ield Leads	and justificatint (*3) Acc			Fail Fail	□ N/A □ N/A □ N/A (*3) □ N/A
Test Engineer		Soraku-guli, Ky	7010 019-0237	Japan 				
Idak	amoto ori Okamoto				2	d		
	RTL02810	A ₁	pproved by	Ikuya I	Minematsu	/ Group I	Manager	

Report Version: A KEC Testing Division